



<p style="text-align: center;">Searched</p> 	<p>Application/Control No.</p> <p>10529759</p>	<p>Applicant(s)/Patent Under Reexamination</p> <p>NAKAMURA, KENJI</p>
	<p>Examiner</p> <p>Al-Nazer, Leith A</p>	<p>Art Unit</p> <p>2821</p>

Class	SubClass	Date	Examiner
315	169.1-169.3	08/30/2006	Leith Al-Nazer

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Search Notes 	Application/Control No. 10529759	Applicant(s)/Patent Under Reexamination NAKAMURA, KENJI
	Examiner Al-Nazer, Leith A	Art Unit 2821

Notes	Date	Examiner
EAST prior art text search (see "Examiner Search Notes")	08/30/2006	Leith Al-Nazer
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